

Search Notes

Application/Control No.

09/729,262

Examiner

Ellen C. Tran

Applicant(s)/Patent under
Reexamination

MURAKAWA, YASUSHI

Art Unit

2134

SEARCHED

Class	Subclass	Date	Examiner
726	15	10/28/2005	ECT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
726	15	10/28/2005	ECT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	10/26/2005	ECT